

<b>Specification</b>	<b>AXIOM40</b>	Rev.: 10	Date: 2014-04-18
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**Oscillator type: High Stability Eurocase OCXO with HCMOS Output**

Parameter	min.	typ.	max.	Unit	Condition
<b>Frequency range</b>	5		125	MHz	
<b>Standard frequencies</b>	10.000/32.768			MHz	
<b>Frequency stability</b>					
Initial tolerance @ +25°C			±300	ppb	V <sub>c</sub> @ VREF/2
vs. operating temperature range	Option 2 & 3 See tables 1 & 2				steady state
vs. supply voltage variation (pushing)			±10	ppb	V <sub>s</sub> ±5%
vs. load change (pulling)			±10	ppb	Load ±10%
Long term (aging) per day (after 30 days operation) (Note 2)			±10 ±2	ppb ppb	AT-Cut SC-Cut
Long term (aging) 1 <sup>st</sup> year (after 30 days operation) (Note 2)		±300 ±50	±500 ±200	ppb ppb	AT-Cut SC-Cut
<b>Frequency adjustment range</b>					
Electronic Frequency Control (EFC)	±2 ±0.8		±5	ppm ppm	AT-Cut SC-Cut
EFC voltage V <sub>c</sub>	0	VREF/2	VREF	V	
EFC slope ( $\Delta f / \Delta V_c$ )	Positive				
EFC input impedance	100			kΩ	
<b>RF output</b>					
Signal waveform	HCMOS				
Load	15			pF	±10%
Symmetry (duty cycle)	40		60	%	@ V <sub>s</sub> /2
Rise & decay time			5	ns	@ 10% ~ 90% V <sub>s</sub>
Warm-up time @ +25°C		3	5	min	$\Delta f_{\text{final}}/f_0 < \pm 0.1$ ppm
<b>Phase Noise</b>	Consult factory				
<b>Reference voltage VREF output</b> (Note 3)		4.0 5.0		V V	Option 1 = "50" Option 1 = "12"
<b>Supply voltage V<sub>s</sub></b>	4.75 11.4	5.0 12.0	5.25 12.6	V V	Option 1 = "50" Option 1 = "12"
<b>Current consumption</b> (steady state) @ +25°C (Note 4)			250 150	mA mA	Option 1 = "50" Option 1 = "12"
<b>Current consumption</b> (warm-up) (Note 4)			600 350	mA mA	Option 1 = "50" Option 1 = "12"
<b>Enclosure (see drawing) (LxWxH)</b> (Note 5)	36.1x27.2x16 max.			mm	IEC 60679-3 CO 08
<b>Weight</b>			25	g	
<b>Packing</b>	Palette				

**Notes:**

1. Terminology and test conditions are according to IEC60679-1 and MIL-PRF-55310, unless otherwise stated
2. Lower aging on request
3. Other reference voltages on request
4. May be higher for wide operating temperature range
5. Lower height H available on request

### Absolute Maximum Ratings

Parameter	min.	max.	Unit	Condition
Supply Voltage $V_S$	-0.5	$V_S + 10\%$	V	$V_S$ to GND
Control Voltage $V_C$	-0.5	15	V	$V_C$ to GND
Storage Temperature	-55	+125	°C	

### Frequency stability vs. temperature

Option 2	Stability [ppb]
05	±5
10	±10
25	±25
50	±50
100	±100
200	±200

Table 1

Lower Temperature		Upper Temperature	
Option 3	T [°C]	Option 3	T [°C]
0	0	A	+50
1	-10	B	+60
2	-20	C	+70
3	-30	D	+75
4	-40	E	+80
5	-55	F	+85

Table 2

Standard: "1B" = -10°C to +60°C

Temperature range [°C]	Frequency stability [Option 2]					
	05	10	25	50	100	200
0 ~ +50	SC	SC	SC	AT	AT	AT
-10 ~ +60	SC	SC	SC	AT	AT	AT
-20 ~ +70	SC	SC	SC	SC	AT	AT
-30 ~ +70	O	SC	SC	SC	SC	AT
-40 ~ +75	O	O	SC	SC	SC	SC
-40 ~ +85	O	O	SC	SC	SC	SC
-55 ~ +85	-	O	O	SC	SC	SC

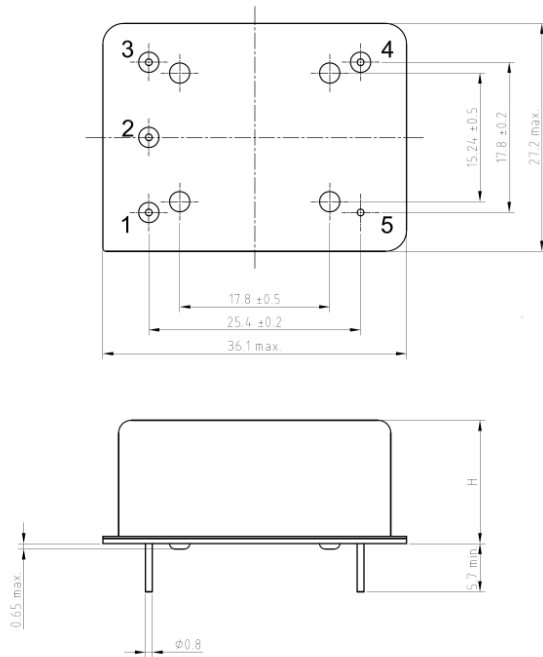
Table 3 "Availability" AT, SC = AT-Cut, SC-Cut available, O = available on request, - not available

### Ordering Code

Model	Option 1 [Supply Voltage]	Option 2 [Stability]	Option 3 [Temperature range]	Revision	Frequency [MHz]
AXIOM40	12, 50	Table 1	Table 2	Rev.10	10.000

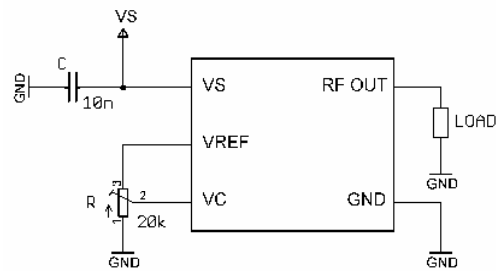
Example: AXIOM40-12-10-1B\_Rev.10 – 10.000 MHz

**Enclosure drawing**



**Pin connections**

Pin #	Symbol	Function
1	V <sub>C</sub>	Control Voltage (EFC)
2	VREF	Reference Voltage
3	V <sub>S</sub>	Supply Voltage
4	RF OUT	RF Output
5	GND	Ground



\* See Application Note AXAN-011

**Handling and Testing**

Parameter	Procedure		Source
Handling and Testing	Application Note AXAN-011		www.axtal.com
Processing	Application Note AXAN-012		www.axtal.com
Parameter	Procedure		Condition
Electrostatic discharge (ESD)			
THD devices	IEC60749-26	HBM	2000 V
SMD devices	IEC60749-27	MM	200 V
Washable	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No		
RoHS- Compliant	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No		

### Environmental conditions

Test	IEC 60068 Part ...	IEC 60679-1 Clause	MIL-STD- 202G Method	MIL-STD- 810F Method	MIL-PRF- 55310D Clause	Test conditions (IEC)
Sealing tests (if applicable)	2-17	5.6.2	112E		3.6.1.2	Gross leak: Test Qc, Fine leak: Test Qk
Solderability Resistance to soldering heat	2-20 2-58	5.6.3	208H 210F		3.6.52 3.6.48	Test Ta Method 1 Test Td <sub>1</sub> Method 2 Test Td <sub>2</sub> Method 2
Shock*	2-27	5.6.8	213B	516.4	3.6.40	Test Ea, 3 x per axes 100g, 6 ms half-sine pulse
Vibration, sinusoidal*	2-6	5.6.7.1	201A 204D	516.4-4	3.6.38.1 3.6.38.2	Test Fc, 30 min per axes, 10 Hz - 55 Hz 0,75mm; 55 Hz - 2 kHz, 10g
Vibration, random*	2-64	5.6.7.3	214A	514.5	3.6.38.3 3.6.38.4	Test Fdb
Endurance tests - ageing - extended aging		5.7.1 5.7.2	108A		4.8.35	30 days @ 85°C, OCXO @25°C 1000h, 2000h, 8000h @85°C

Other environmental conditions on request

Data sheet is for information purposes only and may be subject to modifications or may be discontinued without notice.

### Revision History

Rev.	Drawing	Date [dd.mm.yyyy]	Remarks	Author	Checked
9	D0	11.10.2013	Major revision	CG	BN
10	D0	18.04.2014	Frequency range extended, various parameters updated, environmental conditions updated, editorial changes	HH	HH